

Notice of References Cited	Application/Control No. 10/699,117	Applicant(s)/Patent Under Reexamination PARK ET AL.	
	Examiner Tae H. Yoon	Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,427,799	01-1984	Orlowski et al.	523/116
*	B	US-Re. 32073	01-1986	Randklev	523/117
*	C	US-5,122,061	06-1992	Wakumoto et al.	433/228.1
*	D	US-5,228,907	07-1993	Eppinger et al.	106/35
*	E	US-5,444,104	08-1995	Waknine, Samuel	522/24
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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